

Strain-Versus-Dislocation Model for Understanding the Heteroepitaxial Growth of Nanowires

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Supplemental Material

S1. Strain energy of ZnO nanowire on GaN substrate

To calculate the strain energy of the nanowire on GaN, following derivations are applied:

$$\begin{aligned}u_r(r, \theta, z) &= Br \exp\left(\frac{-z}{2\alpha R}\right) \\u_\theta(r, \theta, z) &= 0 \\u_z(r, \theta, z) &= (Pr + QR) \exp\left(\frac{-z}{2\alpha R}\right)\end{aligned}$$

We have:

$$\begin{aligned}\varepsilon_{rr} &= \frac{\partial u_r}{\partial r} = B \exp\left(\frac{-z}{2\alpha R}\right) \\ \varepsilon_{\theta\theta} &= \frac{u_r}{r} + \frac{1}{r} \frac{\partial u_\theta}{\partial \theta} = B \exp\left(\frac{-z}{2\alpha R}\right) \\ \varepsilon_{zz} &= \frac{\partial u_z}{\partial z} = -\frac{Pr + QR}{2\alpha R} \exp\left(\frac{-z}{2\alpha R}\right) \\ \varepsilon_{rz} &= \frac{1}{2} \left(\frac{\partial u_r}{\partial z} + \frac{\partial u_z}{\partial r} \right) = \frac{-Pr + 2QR\alpha}{4\alpha R} \exp\left(\frac{-z}{2\alpha R}\right) \\ \varepsilon_{r\theta} &= \frac{1}{2} \left(\frac{\partial u_\theta}{\partial r} + \frac{1}{r} \frac{\partial u_r}{\partial \theta} - \frac{u_\theta}{r} \right) = 0 \\ \varepsilon_{z\theta} &= \frac{1}{2} \left(\frac{\partial u_\theta}{\partial z} + \frac{1}{r} \frac{\partial u_z}{\partial \theta} \right) = 0\end{aligned}$$

With Hooke's Law, one obtains:

$$[\sigma] = [C][\varepsilon] = \begin{pmatrix} C_{11} & C_{12} & C_{13} & 0 & 0 & 0 \\ C_{12} & C_{11} & C_{13} & 0 & 0 & 0 \\ C_{13} & C_{13} & C_{33} & 0 & 0 & 0 \\ 0 & 0 & 0 & C_{44} & 0 & 0 \\ 0 & 0 & 0 & 0 & C_{44} & 0 \\ 0 & 0 & 0 & 0 & 0 & C_{66} \end{pmatrix} \begin{pmatrix} \varepsilon_{rr} \\ \varepsilon_{\theta\theta} \\ \varepsilon_{zz} \\ 2\varepsilon_{\theta z} \\ 2\varepsilon_{zr} \\ 2\varepsilon_{r\theta} \end{pmatrix}$$

Then we get the strain energy density:

$$e(r, \theta, z) = \frac{1}{2} \sigma_{ij} \varepsilon_{ij} = \left[\frac{1}{2} C_{11} B^2 + \frac{3}{2} C_{12} B^2 + \frac{C_{33} Q^2}{8\alpha^2} - \frac{C_{13} B Q}{\alpha} + \frac{1}{2} C_{44} P^2 + \left(\frac{C_{33} P^2}{8\alpha^2 R^2} + \frac{C_{44} B^2}{8\alpha^2 R^2} \right) r^2 \right. \\ \left. + \left(\frac{C_{33} P Q}{8\alpha^2 R} - \frac{C_{13} B P}{\alpha R} - \frac{C_{44} B P}{2\alpha R} \right) r \right] \exp\left(\frac{-z}{\alpha R}\right)$$

Integrate the strain energy density in the cylindrical nanowire, we have:

$$E_C = \int_0^H \int_0^{2\pi} \int_0^R e(r, \theta, z) r dr d\theta dz = \frac{\pi R^3}{96\alpha} \left[(48C_{11} B^2 + 144C_{12} B^2 + 48C_{44} P^2) \alpha^2 + (-96C_{13} B Q \right. \\ \left. - 64C_{13} B P - 32C_{44} B P) \alpha + 12C_{33} Q^2 + 8C_{33} P Q + 6C_{33} P^2 + 6C_{44} B^2 \right] \left[1 - \exp\left(\frac{-H}{\alpha R}\right) \right]$$

Assume the substrate is rigid along the radial direction, we have:

$$E_C = \frac{\pi R^3}{96\alpha} \left[(48C_{11} f^2 + 144C_{12} f^2 + 48C_{44} P^2) \alpha^2 - (96C_{13} f Q + 64C_{13} f P + 32C_{44} f P) \alpha + 12C_{33} Q^2 \right. \\ \left. + 8C_{33} P Q + 6C_{33} P^2 + 6C_{44} f^2 \right] \left[1 - \exp\left(\frac{-H}{\alpha R}\right) \right]$$

To minimize E , the 'fminsearch' function in MatLab was applied with three variables. Then we have the strain energy of the ZnO nanowire grown on GaN:

$$E_C^* = E_{min}$$

For instance, for a ZnO nanowire with radius 25 nm and length 5 nm, E_C^* was calculated to be 5.5×10^{-16} J, where α , P and Q were determined to be 0.2737, 0.0117 and 0.0071, respectively.

S2. Shear modulus of ZnO nanowire

Shear modulus G is obtained by following expression:

$$B = \frac{(C_{11} + C_{12})C_{33} - 2C_{13}^2}{C_{11} + C_{12} + 2C_{33} - 4C_{13}}; E = 3B(1 - 2\nu); \nu = \frac{C_{13}}{C_{11} + C_{12}}; G = \frac{E}{2(1 + \nu)}$$

S3. Strain Energy of ZnO nanowire on sapphire substrates

Cartesian coordinate is applied in this calculation considering a tetragonal wire is assumed. The following displacement fields are assumed:

$$\begin{aligned}u_x(x, y, z) &= A \\u_y(x, y, z) &= By \exp\left(\frac{-z}{2\alpha T}\right) \\u_z(x, y, z) &= (Py + QT) \exp\left(\frac{-z}{2\alpha T}\right)\end{aligned}$$

By applying the same method we use for nanowire on GaN, we get the expression of non-minimized strain energy:

$$\begin{aligned}E_C &= \frac{2T^3}{12\alpha} (12C_{11}f^2\alpha^2 - 12C_{13}fQ\alpha + 3C_{33}Q^2 + 12C_{44}P^2\alpha^2 + 4C_{33}P^2 + 4C_{44}f^2 + 6C_{33}PQ \\&- 12C_{13}fP\alpha - 12C_{44}fP\alpha) [1 - \exp\left(\frac{-H}{\alpha T}\right)]\end{aligned}$$

In the calculation of the strain energy, we only considered the 20% lattice mismatch between $(11\bar{2}0)_{\text{ZnO}}$ and $(0001)_{\text{Al}_2\text{O}_3}$. The strain from lattice mismatch between $(1\bar{1}00)_{\text{ZnO}}$ and $(1\bar{1}00)_{\text{Al}_2\text{O}_3}$ was simply ignored due to the likelihood of insignificant strains. This simplification also generated a conservative result of the strain energy, which has been shown to be high enough to be overcome by any possible energy of dislocated systems.

Here, $2T$ is defined as 40 nm. If the length of the NW is 5 nm, E_C^* was calculated to be 2.2×10^{-14} J, where α , P and Q were determined to be 0.9236, 0.0726 and 0.0970, respectively.

S4. Strain energy of ZnO nanofin on GaN and Sapphire

Since we considered both ZnO nanofin on GaN along GaN $[1\bar{1}00]$ direction and ZnO nanofin on sapphire along sapphire $[1\bar{1}00]$ direction are strain free, the same derivation process was used. The displacements fields were assumed as followings:

$$\begin{aligned}u_x(x, y, z) &= A \\u_y(x, y, z) &= By \exp\left(\frac{-z}{2\alpha T}\right) \\u_z(x, y, z) &= (Py + QT) \exp\left(\frac{-z}{2\alpha T}\right)\end{aligned}$$

Similar process as the ZnO nanowire on sapphire, we have:

$$\begin{aligned}E_C &= \frac{WT^2}{12\alpha} (12C_{11}f^2\alpha^2 - 12C_{13}fQ\alpha + 3C_{33}Q^2 + 12C_{44}P^2\alpha^2 + 4C_{33}P^2 + 4C_{44}f^2 + 6C_{33}PQ - 12C_{13}fP\alpha \\&- 12C_{44}fP\alpha) [1 - \exp\left(\frac{-H}{\alpha T}\right)]\end{aligned}$$

For ZnO nanofin on GaN substrate, by assuming $2T$ as 50 nm, width as unit and height as 5 nm, E_C^* was calculated to be $8.3 \times 10^{-9} J$, where α , P and Q were determined to be 1.0539, 0.0075 and 0.0136, respectively.

For ZnO nanofin on sapphire substrate, $2T$ was defined as 40 nm and width was unit. If the height of the ZnO nanofin on sapphire is only 5 nm, E_C^* is calculated to be $5.48 \times 10^{-7} J$, where α , P and Q are determined to be 0.9236, 0.0726 and 0.0970, respectively. In fact, at any thickness starting from 0.5 nm, E_C^* was found greater than E_D^* . Therefore, we concluded that the ZnO nanofin is energy unfavorable structure on sapphire substrate.